

FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	SERIAL NO. 10/668,740	ATTORNEY DOCKET NO. SVL920030067US1
	FILING DATE September 23, 2003	GROUP ART UNIT 2179
	APPLICANT(S): Shyh-Mei F. Ho et al.	

REFERENCE DESIGNATION**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	A1	5,781,739	07/14/1998	Bach et al.	709/227	12/31/1996
	A2	6,128,622	10/03/2000	Bach et al.	707/103	03/13/1998
	A3	6,212,550	04/03/2001	Segur	709/206	01/21/1997
	A4	6,250,309	06/26/2001	Krichen et al.	128/899	07/21/1999
	A5	6,446,110	09/03/2002	Lecton et al.	709/203	04/05/1999
	A6	6,753,889	06/22/2004	Najmi	715/784	10/30/2000
	A7	6,772,206	08/03/2004	Lowry et al.	709/223	06/11/2001
	A8	6,910,216	06/21/2005	Abileah et al.	719/319	11/07/2000
	A9	7,013,306	03/14/2006	Turba et al.	707/101	12/21/2001
	A10	2001/0014900	08/16/2001	Brauer et al.	707/513	02/13/2001
	A11	2002/0056012	05/09/2002	Abileah et al.	709/310	05/04/2001
	A12	2002/0078010	06/20/2002	Ehrman et al.	707/1	05/04/2001
	A13	2002/0100027	07/25/2002	Binding et al.	717/137	07/24/2001
	A14	2002/0133569	09/19/2002	Huang et al.	709/219	03/03/2001
	A15	2002/0161801	10/31/2002	Hind et al.	707/513	04/26/2001
	A16	2002/0174340	11/21/2002	Dick et al.	713/178	05/18/2001
	A17	2002/0178290	11/28/2002	Coulthard et al.	709/246	06/11/2001
	A18	2002/0194227	12/19/2002	Day et al.	707/523	04/18/2001
	A19	2003/0007397	01/09/2003	Kobayashi et al.	365/200	05/10/2002
	A20	2003/0120730	06/26/2003	Kuno et al.	709/204	12/06/2001
	A21	2004/0054969	03/18/2004	Chiang et al.	715/513	09/16/2002
	A22	2004/0054970	03/18/2004	Chiang et al.	715/523	09/16/2002
	A23	2004/0064466	04/01/2004	Manikutty et al.	707/100	05/01/2003
	A24	2004/0103370	05/27/2004	Chiang et al.	715/513	11/27/2002
	A25	2004/0237034	11/25/2004	Chiang et al.	715/513	05/19/2003
	A26	2005/0165826	07/28/2005	Ho et al.	707/102	01/28/2004

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	A27	2005/0165936	07/28/2005	Haller et al.	709/228	01/26/2004
	A28	2005/0203944	09/15/2005	Dinh et al.	707/102	03/18/2005
	A29	2006/0265478	11/23/2006	Chiang et al.	709/219	07/12/2006

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION	
						YES	NO
	A30	WO 01/67290	09/13/2001	WIPO	G06F 17/00		
	A31	JP2001273177	10/05/2001	Japan	G06F 12/00		

NON-PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)
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